## Solutions to Selected Chapter 6 Exercises

- **6.1** From  $\Lambda(T_i) \Lambda(T_{i-1}) \sim Exponential(1)$ , where  $\Lambda(T_i) = \lambda T_i$  for the exponential renewal process, we obtain  $\Lambda(T_i) \Lambda(T_{i-1}) = \lambda T_i \lambda T_{i-1} = \lambda (T_i T_{i-1}) \sim Exponential(1)$ . Consequently,  $T_i T_{i-1} \sim \frac{1}{\lambda} Exponential(1) = Exponential(\lambda)$ .
- **6.2** For failure times  $t_1, t_2, \ldots, t_n, T_1, T_2 T_1, \ldots, T_n T_{n-1}$  are i.i.d.  $Gamma(\alpha, \lambda)$ . The corresponding likelihood is proportional to

$$[\lambda^{\alpha}/\Gamma(\alpha)]^n \left( \prod_{i=1}^n (t_i - t_{i-1})^{\alpha - 1} \right) \exp(-\lambda t_n),$$

where  $t_0 = 0$ . Under Type-I censoring at  $t_c$ , the corresponding likelihood is proportional to

$$[\lambda^{\alpha}/\Gamma(\alpha)]^n \left( \prod_{i=1}^n (t_i - t_{i-1})^{\alpha - 1} \right) \exp(-\lambda t_n) \int_{t_c - t_n}^{\infty} f(t|\alpha, \lambda) dt,$$

where  $f(t|\alpha, \lambda)$  is the  $Gamma(\alpha, \lambda)$  probability density function. Type-II censoring is not relevant for a single repairable system.

- **6.4** A 95% credible interval for  $\kappa$  is (0.473, 1.120), so that the data suggest that there is no need to use the MPLP over the PLP, where  $\kappa$  equals 1. Accounting for the censored observation,  $26^{0.4} \approx 4$ . Using K=4 equal probability bins, we find that 1.3% of the  $R^B$  test statistics exceed the 0.95 quantile of the ChiSquared(3) reference distribution, which suggests no lack of fit.
- **6.8** If the last failure occurred at  $t^*$ , we have  $\Lambda(T+t^*)-\Lambda(t^*)\sim Gamma(\kappa,1)$  so that  $R_{t^*}(t)=\mathbf{P}(T>t)$ , but

$$T>t\equiv \Lambda^{-1}\left(\Lambda(t*)+X\right)-t^*>t\equiv X>\Lambda(t+t^*)-\Lambda(t^*)\,,$$

where  $X \sim Gamma(\kappa, 1)$ . Consequently,

$$R_{t^*}(t) = \int_{\Lambda(t+t^*)-\Lambda(t^*)}^{\infty} f(x|\kappa, 1) dt,$$

where  $f(x|\kappa, 1)$  is the  $Gamma(\kappa, 1)$  probability density function.

**6.20** Assuming that uptime  $U \sim Gamma(\alpha_U, \lambda_U)$  and downtime  $D \sim Gamma(\alpha_D, \lambda_D)$ , then the long-run availability  $A = \frac{E(U)}{E(U) + E(D)}$  is

$$\frac{\alpha_U/\lambda_U}{\alpha_U/\lambda_U+\alpha_D/\lambda_D}.$$